

## Double channel high-side driver with analog current sense for automotive applications

Datasheet - production data



- Load current limitation
- Self limiting of fast thermal transients
- Protection against loss of ground and loss of  $V_{CC}$
- Overtemperature shutdown with auto restart (thermal shutdown)
- Reverse battery protection with self switch on of the Power MOSFET
- Electrostatic discharge protection

### Features

Max transient supply voltage	$V_{CC}$	41V
Operating voltage range	$V_{CC}$	4.5 to 28V
Max on-state resistance (per ch.)	$R_{ON}$	12 m $\Omega$
Current limitation (typ)	$I_{LIMH}$	74 A
Off-state supply current	$I_S$	2 $\mu A^{(1)}$

1. Typical value with all loads connected.

- General
  - Inrush current active management by power limitation
  - Very low standby current
  - 3.0V CMOS compatible inputs
  - Optimized electromagnetic emissions
  - Very low electromagnetic susceptibility
  - In compliance with the 2002/95/EC european directive
  - Very low current sense leakage
- Diagnostic functions
  - Proportional load current sense
  - High current sense precision for wide current range
  - Current sense disable
  - Overload and short to ground (power limitation) indication
  - Thermal shutdown indication
- Protections
  - Undervoltage shutdown
  - Overvoltage clamp

### Applications

- All types of resistive, inductive and capacitive loads
- Suitable as LED driver

### Description

The VND5E012MY-E is a double channel high-side driver manufactured in the STMicroelectronics® VIPower® M0-5 technology and housed in the tiny PowerSSO-36 package. The VND5E012MY-E is designed to drive 12 V automotive grounded loads delivering protection, diagnostics and easy 3 V and 5 V CMOS compatible interface with any microcontroller.

The device integrates advanced protective functions such as load current limitation, inrush and overload active management by power limitation, overtemperature shut-off with auto restart and over-voltage active clamp. A dedicated analog current sense pin is associated with every output channel in order to provide *Enhanced* diagnostic functions including fast detection of overload and short-circuit to ground through power limitation indication and overtemperature indication.

The current sensing and diagnostic feedback of the whole device can be disabled by pulling the CS\_DIS pin high to allow sharing of the external sense resistor with other similar devices.

# Contents

<b>1</b>	<b>Block diagram and pin description</b> .....	<b>5</b>
<b>2</b>	<b>Electrical specifications</b> .....	<b>7</b>
2.1	Absolute maximum ratings .....	7
2.2	Thermal data .....	8
2.3	Electrical characteristics .....	9
2.4	Waveforms .....	18
2.5	Electrical characteristics curves .....	20
<b>3</b>	<b>Application information</b> .....	<b>23</b>
3.1	Load dump protection .....	23
3.2	MCU I/Os protection .....	23
3.3	Current sense and diagnostic .....	24
3.4	Maximum demagnetization energy (VCC = 13.5V) .....	25
<b>4</b>	<b>Package and PCB thermal data</b> .....	<b>26</b>
4.1	PowerSSO-36 thermal data .....	26
<b>5</b>	<b>Package information</b> .....	<b>30</b>
5.1	ECOPACK <sup>®</sup> package .....	30
5.2	PowerSSO-36 mechanical data .....	31
5.3	Packing information .....	33
<b>6</b>	<b>Order codes</b> .....	<b>34</b>
<b>7</b>	<b>Revision history</b> .....	<b>35</b>

## List of tables

Table 1.	Pin function . . . . .	5
Table 2.	Suggested connections for unused and not connected pins . . . . .	6
Table 3.	Absolute maximum rating . . . . .	7
Table 4.	Thermal data . . . . .	8
Table 5.	Power section . . . . .	9
Table 6.	Switching ( $V_{CC} = 13V$ ; $T_j = 25^{\circ}C$ ) . . . . .	9
Table 7.	Logic inputs . . . . .	10
Table 8.	Protections and diagnostics . . . . .	10
Table 9.	Current sense ( $8V < V_{CC} < 18V$ ) . . . . .	11
Table 10.	Truth table . . . . .	16
Table 11.	Electrical transient requirements (part 1) . . . . .	17
Table 12.	Electrical transient requirements (part 2) . . . . .	17
Table 13.	Electrical transient requirements (part 3) . . . . .	17
Table 14.	Thermal parameter . . . . .	28
Table 15.	PowerSSO-36 mechanical data . . . . .	32
Table 16.	Device summary . . . . .	34
Table 17.	Document revision history . . . . .	35

## List of figures

Figure 1.	Block diagram . . . . .	5
Figure 2.	Configuration diagram (top view) . . . . .	6
Figure 3.	Current and voltage conventions . . . . .	7
Figure 4.	Current sense delay characteristics . . . . .	12
Figure 5.	Switching characteristics . . . . .	13
Figure 6.	Delay response time between rising edge of output current and rising edge of current sense (CS enabled) . . . . .	14
Figure 7.	Output voltage drop limitation . . . . .	14
Figure 8.	$I_{OUT}/I_{SENSE}$ vs $I_{OUT}$ . . . . .	15
Figure 9.	Maximum current sense ratio drift vs load current . . . . .	15
Figure 10.	Normal operation . . . . .	18
Figure 11.	Overload or short to GND . . . . .	18
Figure 12.	Intermittent overload . . . . .	19
Figure 13.	$T_J$ evolution in overload or short to GND . . . . .	19
Figure 14.	Off-state output current . . . . .	20
Figure 15.	High level input current . . . . .	20
Figure 16.	Input clamp voltage . . . . .	20
Figure 17.	Input high level voltage . . . . .	20
Figure 18.	Input low level voltage . . . . .	20
Figure 19.	Input hysteresis voltage . . . . .	20
Figure 20.	On-state resistance vs $T_{case}$ . . . . .	21
Figure 21.	On-state resistance vs $V_{CC}$ . . . . .	21
Figure 22.	Undervoltage shutdown . . . . .	21
Figure 23.	$I_{LIMH}$ vs $T_{case}$ . . . . .	21
Figure 24.	Turn-on voltage slope . . . . .	21
Figure 25.	Turn-off voltage slope . . . . .	21
Figure 26.	CS_DIS clamp voltage . . . . .	22
Figure 27.	Low level CS_DIS voltage . . . . .	22
Figure 28.	High level CS_DIS voltage . . . . .	22
Figure 29.	Application schematic . . . . .	23
Figure 30.	Current sense and diagnostic . . . . .	24
Figure 31.	Maximum turn-off current versus inductance . . . . .	25
Figure 32.	PowerSSO-36 PC board . . . . .	26
Figure 33.	$R_{thj-amb}$ vs PCB copper area in open box free air condition (one channel ON) . . . . .	27
Figure 34.	PowerSSO-36 thermal impedance junction ambient single pulse (one channel ON) . . . . .	27
Figure 35.	Thermal fitting model of a double channel HSD in PowerSSO-36 <sup>(1)</sup> . . . . .	28
Figure 36.	PowerSSO-36 package dimensions . . . . .	31
Figure 37.	PowerSSO-36 tube shipment (no suffix) . . . . .	33
Figure 38.	PowerSSO-36 tape and reel shipment (suffix "TR") . . . . .	33

# 1 Block diagram and pin description

Figure 1. Block diagram

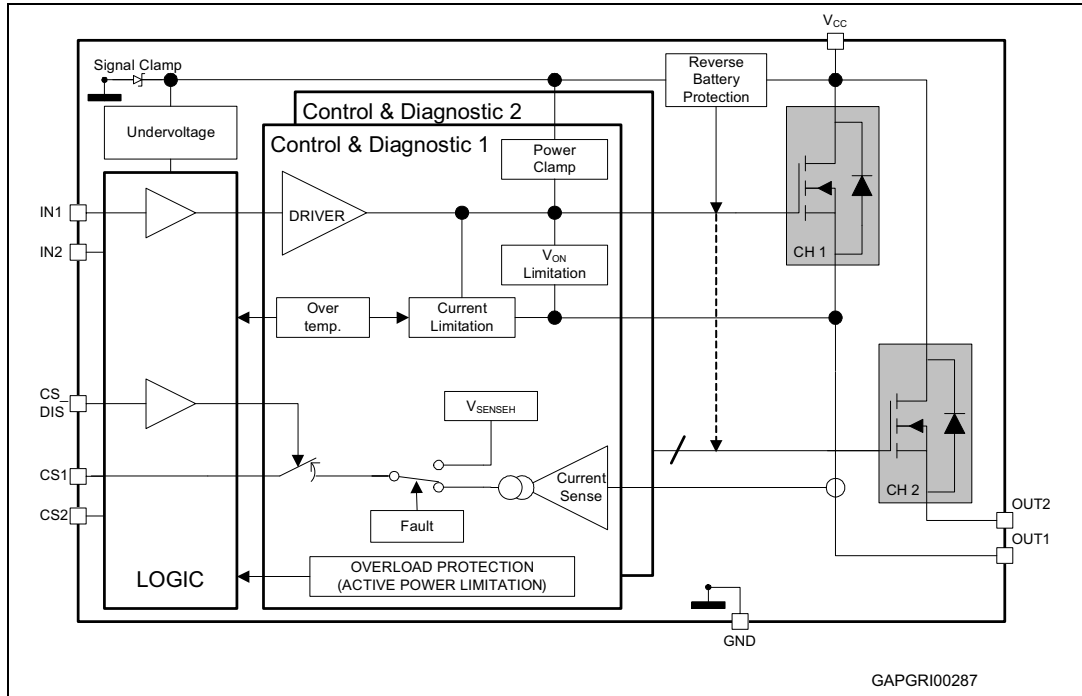


Table 1. Pin function

Name	Function
V <sub>CC</sub>	Battery connection
OUT <sub>1,2</sub>	Power output
GND	Ground connection
IN <sub>1,2</sub>	Voltage controlled input pin with hysteresis, CMOS compatible. Controls output switch state
CS <sub>1,2</sub>	Analog current sense pin, delivers a current proportional to the load current
CS_DIS	Active high CMOS compatible pin, to disable the current sense pin

Figure 2. Configuration diagram (top view)

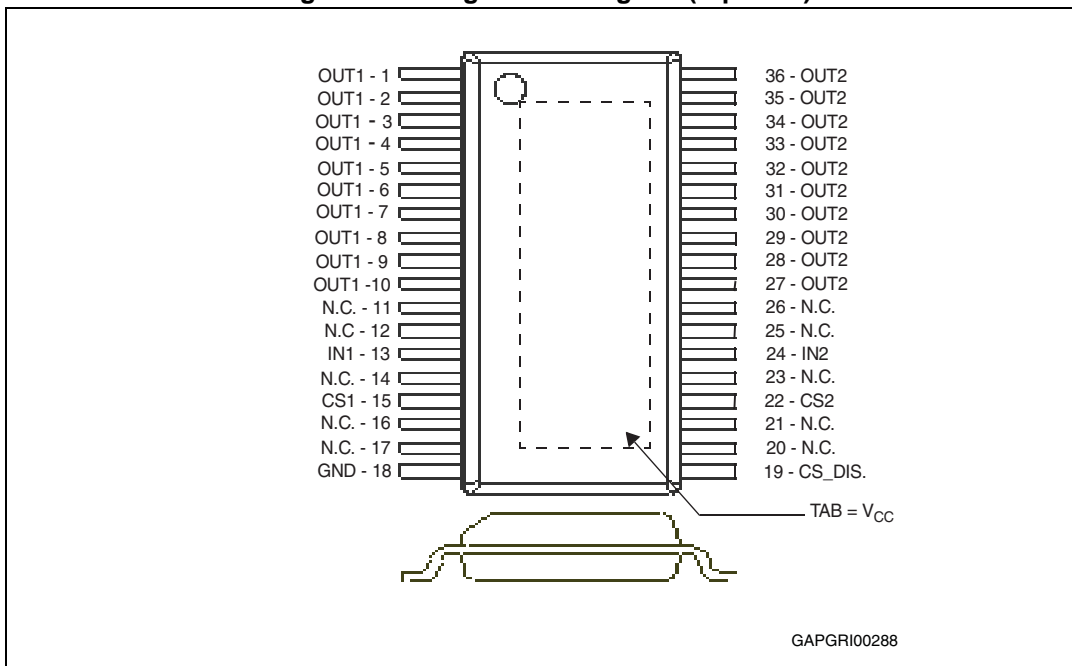
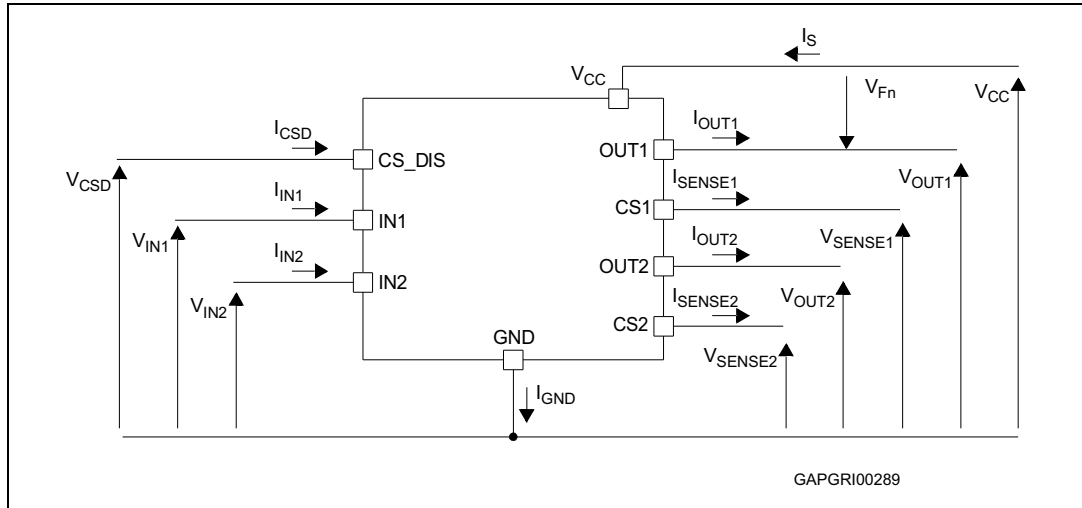


Table 2. Suggested connections for unused and not connected pins

Connection / pin	Current Sense	N.C.	Output	Input	CS_DIS
Floating	Not allowed	X	X	X	X
To ground	Through 1 KΩ resistor	X	Not allowed	Through 10 KΩ resistor	Through 10 KΩ resistor

## 2 Electrical specifications

Figure 3. Current and voltage conventions



### 2.1 Absolute maximum ratings

Applying stress which exceeds the ratings listed in the [Table 3](#) may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to the conditions in this section for extended periods may affect device reliability.

Table 3. Absolute maximum rating

Symbol	Parameter	Value	Unit
$V_{CC}$	DC supply voltage	28	V
$V_{CCPK}$	Transient supply voltage ( $T < 400\text{ms}$ , $R_{LOAD} > 0.5\Omega$ )	41	V
$-V_{CC}$	Reverse DC supply voltage	16	V
$V_{CC\_LSC}$	Maximum supply voltage for full protection to short-circuit (acc. AEC-Q100-012)	18	V
$I_{OUT}$	DC output current	Internally limited	A
$-I_{OUT}$	Reverse DC output current	50	A
$I_{IN}$	DC input current	-1 to 10	mA
$I_{CSD}$	DC current sense disable input current	-1 to 10	mA
$V_{CSENSE}$	Current sense maximum voltage	$V_{CC}-41$ $+V_{CC}$	V V
$E_{MAX}$	Maximum switching energy (single pulse) ( $L = 0.47\text{ mH}$ ; $R_L = 0\ \Omega$ ; $V_{bat} = 13.5\text{ V}$ ; $T_{jstart} = 150\text{ }^\circ\text{C}$ ; $I_{OUT} = I_{limL}(\text{Typ.})$ )	110	mJ

Table 3. Absolute maximum rating (continued)

Symbol	Parameter	Value	Unit
V <sub>ESD</sub>	Electrostatic discharge (Human Body Model: R=1.5KΩ; C=100pF)		
	– V <sub>CC</sub> , OUTPUT	5000	V
	– INPUT, CS_DIS	4000	
	– CURRENT SENSE	2000	
V <sub>ESD</sub>	Charge device model (CDM-AEC-Q100-011)	750	V
T <sub>j</sub>	Junction operating temperature	-40 to 150	°C
T <sub>stg</sub>	Storage temperature	-55 to 150	°C

## 2.2 Thermal data

Table 4. Thermal data

Symbol	Parameter	Maximum value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case (MAX) (with one channel ON)	2	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-ambient (MAX)	See <a href="#">Figure 33</a> in the thermal section	°C/W



## 2.3 Electrical characteristics

Values specified in this section are for  $8V < V_{CC} < 28V$ ;  $-40^{\circ}C < T_j < 150^{\circ}C$ , unless otherwise specified.

**Table 5. Power section**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{CC}$	Operating supply voltage		4.5	13	28	V
$V_{USD}$	Undervoltage shutdown			3.5	4.5	V
$V_{USDhyst}$	Undervoltage shutdown hysteresis			0.5		V
$R_{ON}$	On-state resistance	$I_{OUT} = 5A$ ; $T_j = 25^{\circ}C$		11		m $\Omega$
		$I_{OUT} = 5A$ ; $T_j = 150^{\circ}C$			24	m $\Omega$
		$I_{OUT} = 5A$ ; $V_{CC} = 5V$ ; $T_j = 25^{\circ}C$			16	m $\Omega$
$R_{ON REV}$	Reverse battery on-state resistance	$V_{CC} = -13V$ ; $I_{OUT} = -5A$ ; $T_j = 25^{\circ}C$			12	m $\Omega$
$V_{clamp}$	Clamp voltage	$I_S = 20 mA$	41	46	52	V
$I_S$	Supply current	Off-state; $V_{CC} = 13V$ ; $T_j = 25^{\circ}C$ ; $V_{IN} = V_{OUT} = V_{SENSE} = V_{CSD} = 0V$		2 <sup>(1)</sup>	5 <sup>(1)</sup>	$\mu A$
		On-state; $V_{CC} = 13V$ ; $V_{IN} = 5V$ ; $I_{OUT} = 0A$		3.5	6.5	mA
$I_{L(off)}$	Off-state output current <sup>(2)</sup>	$V_{IN} = V_{OUT} = 0V$ ; $V_{CC} = 13V$ ; $T_j = 25^{\circ}C$	0	0.01	3	
		$V_{IN} = V_{OUT} = 0V$ ; $V_{CC} = 13V$ ; $T_j = 125^{\circ}C$	0		5	$\mu A$

1. PowerMOS leakage included.

2. For each channel.

**Table 6. Switching ( $V_{CC} = 13V$ ;  $T_j = 25^{\circ}C$ )**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$R_L = 2.6\Omega$ (see <a href="#">Figure 5</a> )	-	30	-	$\mu s$
$t_{d(off)}$	Turn-off delay time	$R_L = 2.6\Omega$ (see <a href="#">Figure 5</a> )	-	20	-	$\mu s$
$(dV_{OUT}/dt)_{on}$	Turn-on voltage slope	$R_L = 2.6\Omega$	-	See <a href="#">Figure 24</a>	-	V/ $\mu s$
$(dV_{OUT}/dt)_{off}$	Turn-off voltage slope	$R_L = 2.6\Omega$	-	See <a href="#">Figure 25</a>	-	V/ $\mu s$
$W_{ON}$	Switching energy losses during $t_{WON}$	$R_L = 2.6\Omega$ (see <a href="#">Figure 5</a> )	-	1	-	mJ
$W_{OFF}$	Switching energy losses during $t_{WOFF}$	$R_L = 2.6\Omega$ (see <a href="#">Figure 5</a> )	-	0.5	-	mJ

Table 7. Logic inputs

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{IL}$	Input low level voltage				0.9	V
$I_{IL}$	Low level input current	$V_{IN}= 0.9V$	1			$\mu A$
$V_{IH}$	Input high level voltage		2.1			V
$I_{IH}$	High level input current	$V_{IN}= 2.1V$			10	$\mu A$
$V_{I(hyst)}$	Input hysteresis voltage		0.25			V
$V_{ICL}$	Input clamp voltage	$I_{IN}= 1mA$ $I_{IN}= -1mA$	5.5	-0.7	7	V V
$V_{CSDL}$	CS_DIS low level voltage				0.9	V
$I_{CSDL}$	Low level CS_DIS current	$V_{CSD}= 0.9V$	1			$\mu A$
$V_{CSDH}$	CS_DIS high level voltage		2.1			V
$I_{CSDH}$	High level CS_DIS current	$V_{CSD}= 2.1V$			10	$\mu A$
$V_{CSD(hyst)}$	CS_DIS hysteresis voltage		0.25			V
$V_{CSCL}$	CS_DIS clamp voltage	$I_{CSD}= 1mA$ $I_{CSD}= -1mA$	5.5	-0.7	7	V V

Table 8. Protections and diagnostics <sup>(1)</sup>

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{limH}$	DC short circuit current	$V_{CC}=13V$ $5V < V_{CC} < 18V$	52	74	104 104	A A
$I_{limL}$	Short circuit current during thermal cycling	$V_{CC}=13V; T_R < T_J < T_{TSD}$		18.5		A
$T_{TSD}$	Shutdown temperature		150	175	200	$^{\circ}C$
$T_R$	Reset temperature		$T_{RS} + 1$	$T_{RS} + 5$		$^{\circ}C$
$T_{RS}$	Thermal reset of status		135			$^{\circ}C$
$T_{HYST}$	Thermal hysteresis ( $T_{TSD} - T_R$ )			7		$^{\circ}C$
$V_{DEMAG}$	Turn-off output voltage clamp	$I_{OUT}=2A; V_{IN}=0; L=6mH$	$V_{CC} - 28$	$V_{CC} - 31$	$V_{CC} - 35$	V
$V_{ON}$	Output voltage drop limitation	$I_{OUT}=0.4A; T_J=-40^{\circ}C...150^{\circ}C$ (see <a href="#">Figure 7</a> )		25		mV

1. To ensure long term reliability under heavy overload or short circuit conditions, protection and related diagnostic signals must be used together with a proper software strategy. If the device is subjected to abnormal conditions, this software must limit the duration and number of activation cycles.

Table 9. Current sense (8V<V<sub>CC</sub><18V)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
K <sub>0</sub>	I <sub>OUT</sub> /I <sub>SENSE</sub>	I <sub>OUT</sub> =0.25A; V <sub>SENSE</sub> =0.5V T <sub>J</sub> = -40°C...150°C	2615	5130	7770	
K <sub>1</sub>	I <sub>OUT</sub> /I <sub>SENSE</sub>	I <sub>OUT</sub> =5A; V <sub>SENSE</sub> =0.5V T <sub>J</sub> =-40°C...150°C T <sub>J</sub> =25°C...150°C	4155 4530	5330 5330	6650 6130	
dK <sub>1</sub> /K <sub>1</sub> <sup>(1)</sup>	Current sense ratio drift	I <sub>OUT</sub> =5A; V <sub>SENSE</sub> = 0.5V; V <sub>CSD</sub> =0V; T <sub>J</sub> = -40 °C to 150 °C	-8		8	%
K <sub>2</sub>	I <sub>OUT</sub> /I <sub>SENSE</sub>	I <sub>OUT</sub> =10A; V <sub>SENSE</sub> =4V T <sub>J</sub> =-40°C...150°C T <sub>J</sub> =25°C...150°C	4705 4865	5290 5290	5950 5715	
dK <sub>2</sub> /K <sub>2</sub> <sup>(1)</sup>	Current sense ratio drift	I <sub>OUT</sub> = 10 A; V <sub>SENSE</sub> = 4 V; V <sub>CSD</sub> =0V; T <sub>J</sub> = -40 °C to 150 °C	-5		5	%
K <sub>3</sub>	I <sub>OUT</sub> /I <sub>SENSE</sub>	I <sub>OUT</sub> =25A; V <sub>SENSE</sub> =4V T <sub>J</sub> =-40°C...150°C T <sub>J</sub> =25°C...150°C	4935 4985	5250 5250	5565 5515	
dK <sub>3</sub> /K <sub>3</sub> <sup>(1)</sup>	Current sense ratio drift	I <sub>OUT</sub> = 25 A; V <sub>SENSE</sub> = 4 V; V <sub>CSD</sub> = 0V; T <sub>J</sub> = -40 °C to 150 °C	-4		4	%
I <sub>SENSE0</sub>	Analog sense leakage current	I <sub>OUT</sub> =0A; V <sub>SENSE</sub> =0V; V <sub>CSD</sub> =5V; V <sub>IN</sub> =0V; T <sub>J</sub> =-40°C...150°C	0		1	μA
		V <sub>CSD</sub> =0V; V <sub>IN</sub> =5V; T <sub>J</sub> =-40°C...150°C	0		2	μA
		I <sub>OUT</sub> =5A; V <sub>SENSE</sub> =0V; V <sub>CSD</sub> =V <sub>IN</sub> =5V;	0		1	μA
V <sub>SENSE</sub>	Max analog sense output voltage	I <sub>OUT</sub> =15A; V <sub>CSD</sub> =0V	5			V
V <sub>SENSEH</sub>	Analog sense output voltage in fault condition <sup>(2)</sup>	V <sub>CC</sub> =13V; R <sub>SENSE</sub> =10KΩ		8		V
I <sub>SENSEH</sub>	Analog sense output current in fault condition <sup>(2)</sup>	V <sub>CC</sub> =13V; V <sub>SENSE</sub> =5V		9		mA
t <sub>DSSENSE1H</sub>	Delay response time from falling edge of CS_DIS pin	V <sub>SENSE</sub> <4V, 1.5A<I <sub>OUT</sub> <25A I <sub>SENSE</sub> =90% of I <sub>SENSE max</sub> (see <a href="#">Figure 4</a> )		50	100	μs
t <sub>DSSENSE1L</sub>	Delay response time from rising edge of CS_DIS pin	V <sub>SENSE</sub> <4V, 1.5A<I <sub>OUT</sub> <25A I <sub>SENSE</sub> =10% of I <sub>SENSE max</sub> (see <a href="#">Figure 4</a> )		5	20	μs

**Table 9. Current sense (8V<V<sub>CC</sub><18V) (continued)**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
t <sub>DSENSE2H</sub>	Delay response time from rising edge of INPUT pin	V <sub>SENSE</sub> <4V, 1.5A<I <sub>out</sub> <25A I <sub>SENSE</sub> =90% of I <sub>SENSE max</sub> (see <a href="#">Figure 4</a> )		70	300	μs
Δt <sub>DSENSE2H</sub>	Delay response time between rising edge of output current and rising edge of current sense	V <sub>SENSE</sub> < 4V, I <sub>SENSE</sub> = 90% of I <sub>SENSEMAX</sub> , I <sub>OUT</sub> = 90% of I <sub>OUTMAX</sub> I <sub>OUTMAX</sub> = 5A (see <a href="#">Figure 6</a> )			300	μs
t <sub>DSENSE2L</sub>	Delay response time from falling edge of INPUT pin	V <sub>SENSE</sub> <4V, 1.5A<I <sub>out</sub> <25A I <sub>SENSE</sub> =10% of I <sub>SENSE max</sub> (see <a href="#">Figure 4</a> )		100	250	μs

1. Parameter guaranteed by design; it is not tested.
2. Fault condition includes: power limitation and overtemperature.

**Figure 4. Current sense delay characteristics**

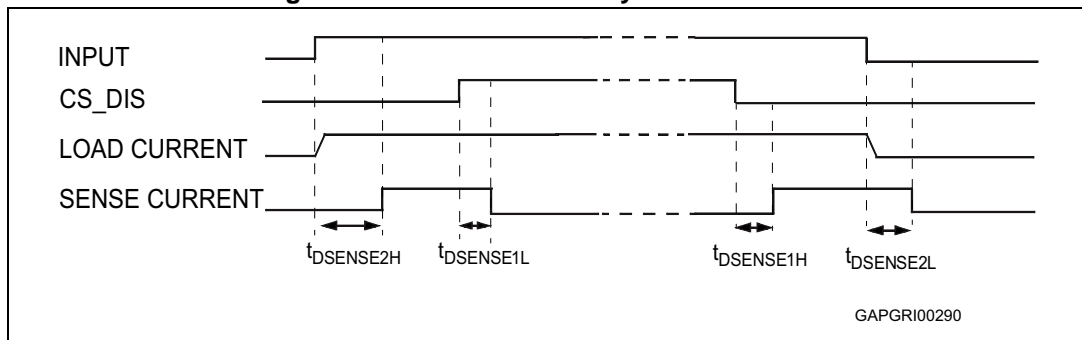


Figure 5. Switching characteristics

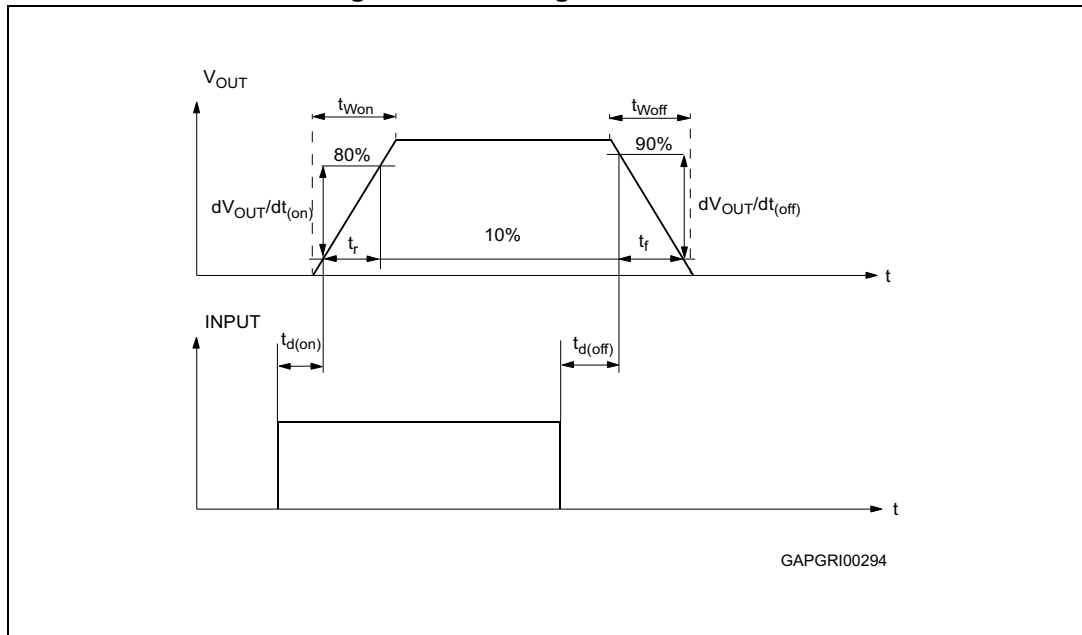


Figure 6. Delay response time between rising edge of output current and rising edge of current sense (CS enabled)

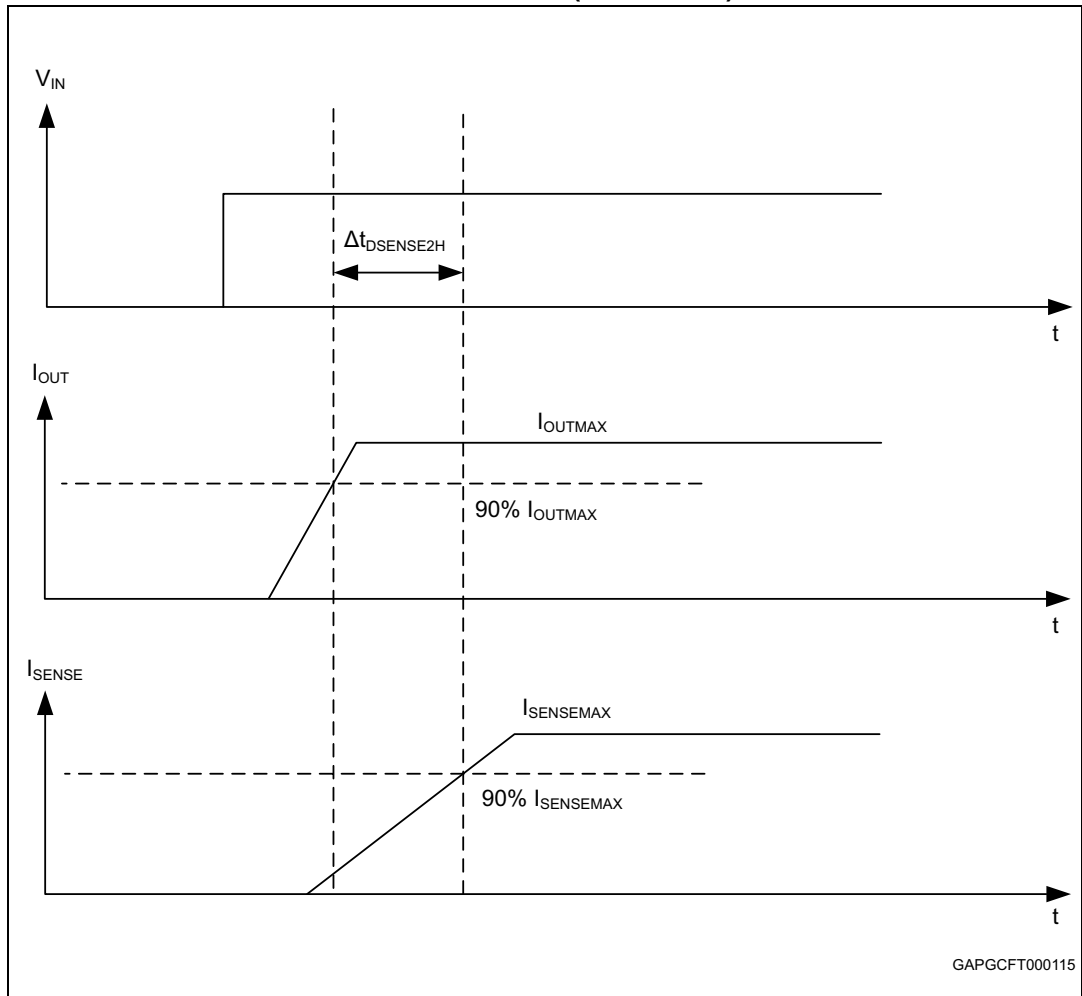


Figure 7. Output voltage drop limitation

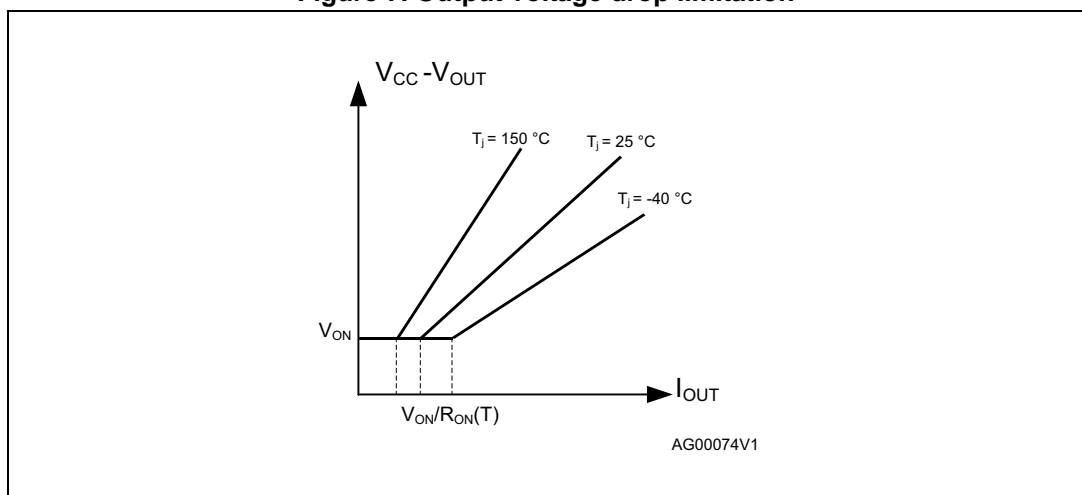


Figure 8.  $I_{OUT}/I_{SENSE}$  vs  $I_{OUT}$

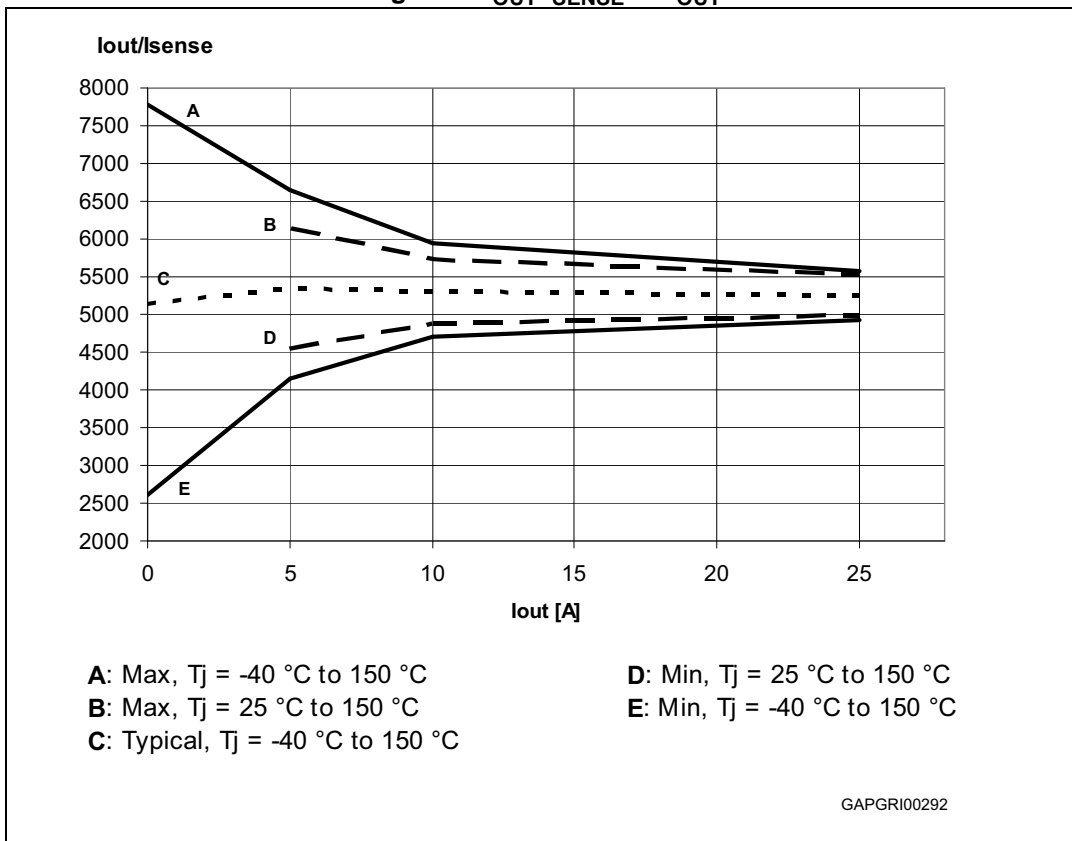
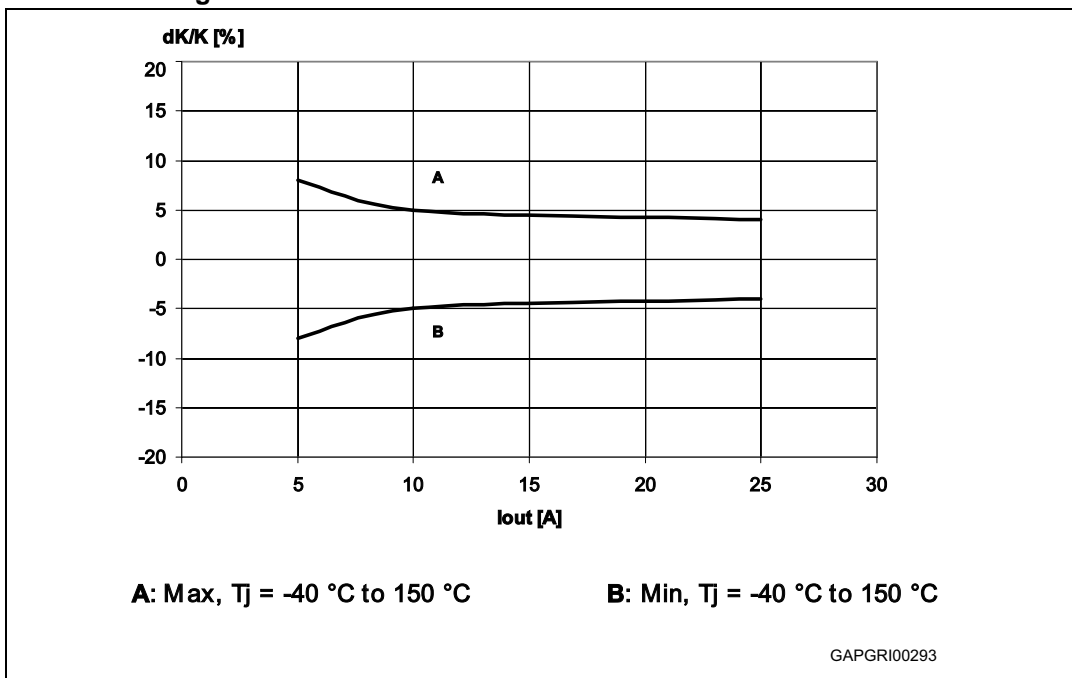


Figure 9. Maximum current sense ratio drift vs load current



Note: Parameter guaranteed by design; it is not tested.



Table 10. Truth table

Conditions	Input	Output	Sense ( $V_{CSD}=0V$ ) <sup>(1)</sup>
Normal operation	L	L	0
	H	H	Nominal
Overtemperature	L	L	0
	H	L	$V_{SENSEH}$
Undervoltage	L	L	0
	H	L	0
Overload	H	X (no power limitation)	Nominal
	H	Cycling (power limitation)	$V_{SENSEH}$
Short circuit to GND (Power limitation)	L	L	0
	H	L	$V_{SENSEH}$
Negative output voltage clamp	L	L	0

1. If the  $V_{CSD}$  is high, the SENSE output is at a high impedance, its potential depends on leakage currents and external circuit.



Table 11. Electrical transient requirements (part 1)

ISO 7637-2: 2004(E) Test pulse	Test levels <sup>(1)</sup>		Number of pulses or test times	Burst cycle/pulse repetition time		Delays and impedance
	III	IV				
1	-75 V	-100 V	5000 pulses	0.5 s	5 s	2 ms, 10 Ω
2a	+37 V	+50 V	5000 pulses	0.2 s	5 s	50 μs, 2 Ω
3a	-100 V	-150 V	1h	90 ms	100 ms	0.1 μs, 50 Ω
3b	+75 V	+100 V	1h	90 ms	100 ms	0.1 μs, 50 Ω
4	-6 V	-7 V	1 pulse			100 ms, 0.01 Ω
5b <sup>(2)</sup>	+65 V	+87 V	1 pulse			400 ms, 2 Ω

1. The above test levels must be considered referred to  $V_{CC} = 13.5$  V except for pulse 5b.
2. Valid in case of external load dump clamp: 40V maximum referred to ground. The protection strategy allows PowerMOS to be cyclically switched on during load dump, so distributing the load dump energy along the time and to transfer a part of it to the load.

Table 12. Electrical transient requirements (part 2)

ISO 7637-2: 2004(E) Test pulse	Test level results <sup>(1)</sup>	
	III	IV
1	C	C
2a	C	C
3a	C	C
3b	C	C
4	C	C
5b <sup>(2)(3)</sup>	C	C

1. The above test levels must be considered referred to  $V_{CC} = 13.5$  V except for pulse 5b
2. Valid in case of external load dump clamp: 40V maximum referred to ground. The protection strategy allows PowerMOS to be cyclically switched on during load dump, so distributing the load dump energy along the time and to transfer a part of it to the load.
3. Suppressed load dump (pulse 5b) is withstood with a minimum load connected as specified in [Table 3: Absolute maximum rating](#).

Table 13. Electrical transient requirements (part 3)

Class	Contents
C	All functions of the device are performed as designed after exposure to disturbance.
E	One or more functions of the device are not performed as designed after exposure to disturbance and cannot be returned to proper operation without replacing the device.

## 2.4 Waveforms

Figure 10. Normal operation

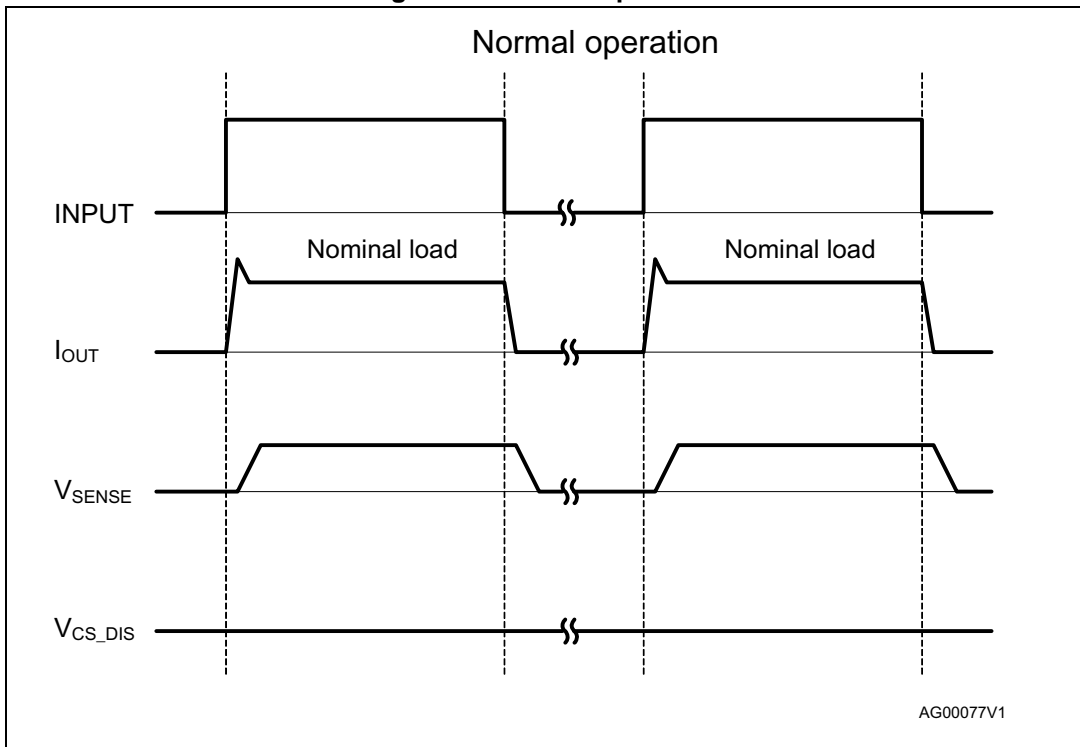


Figure 11. Overload or short to GND

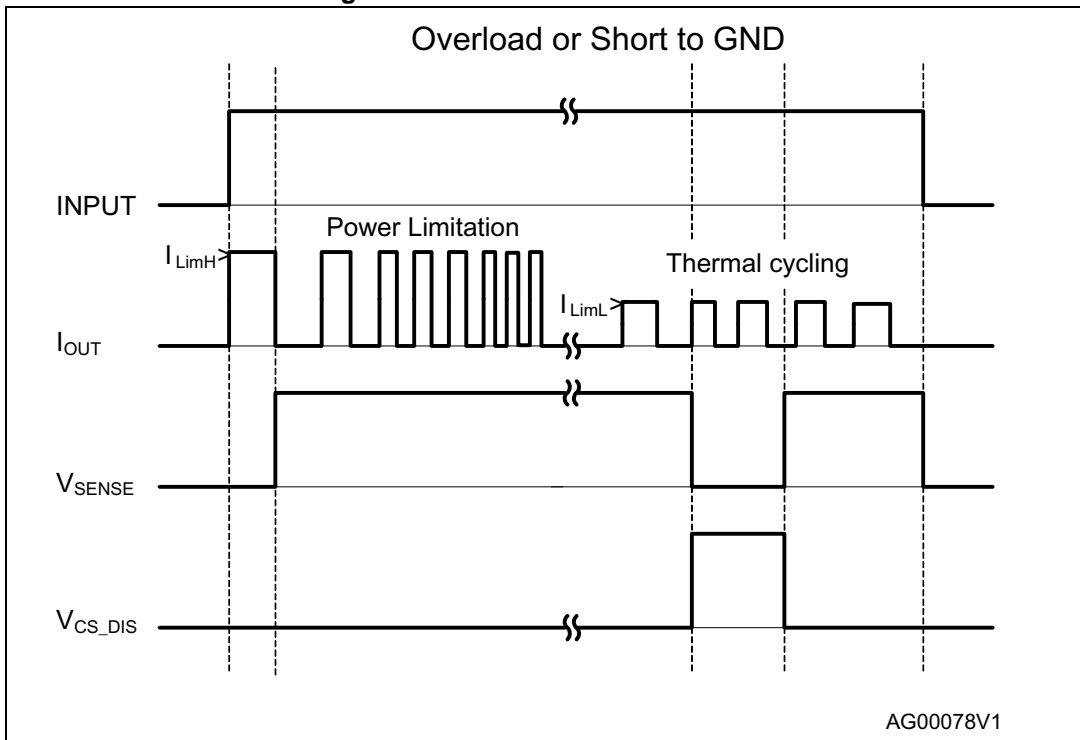


Figure 12. Intermittent overload

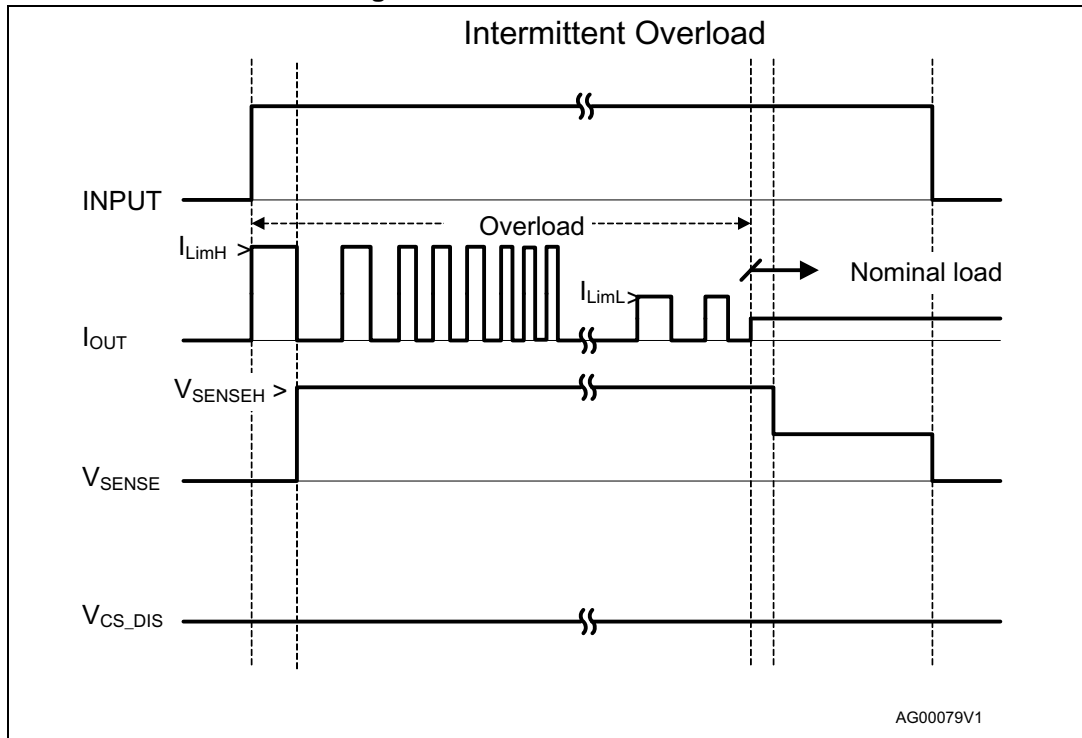
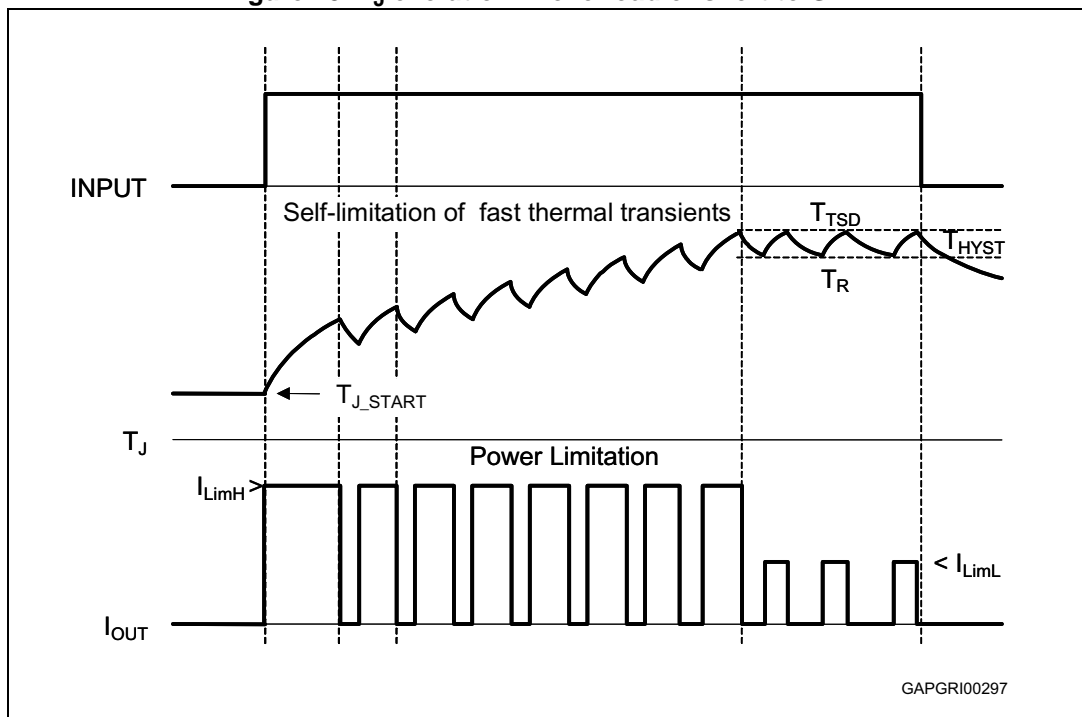


Figure 13. T<sub>J</sub> evolution in overload or short to GND



## 2.5 Electrical characteristics curves

Figure 14. Off-state output current

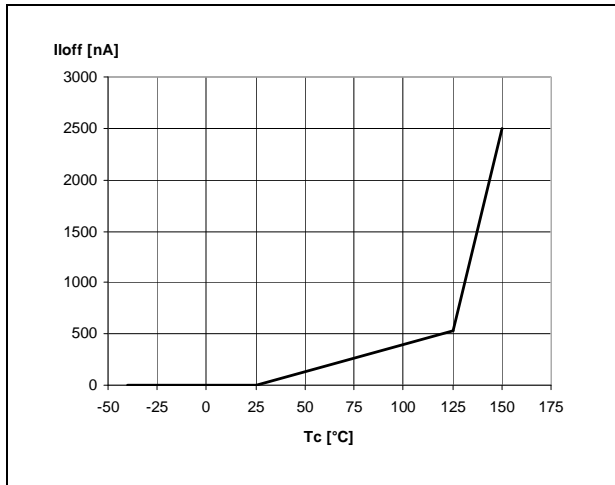


Figure 15. High level input current

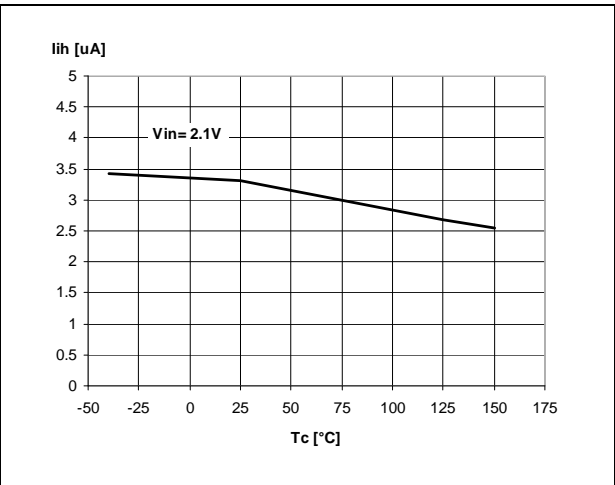


Figure 16. Input clamp voltage

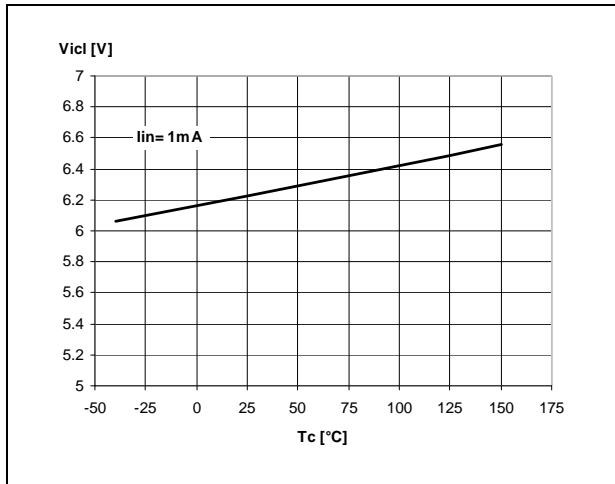


Figure 17. Input high level voltage

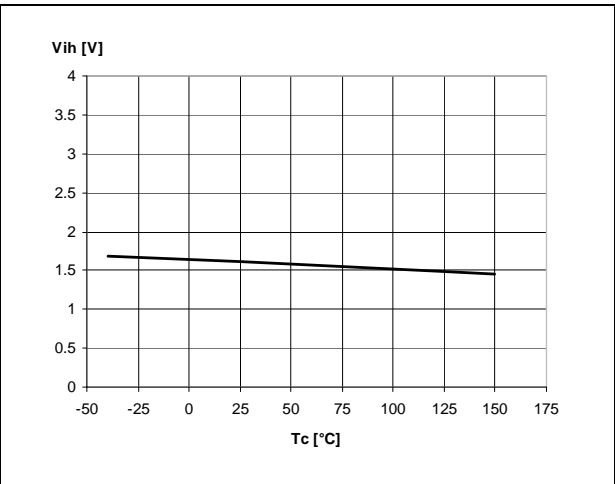


Figure 18. Input low level voltage

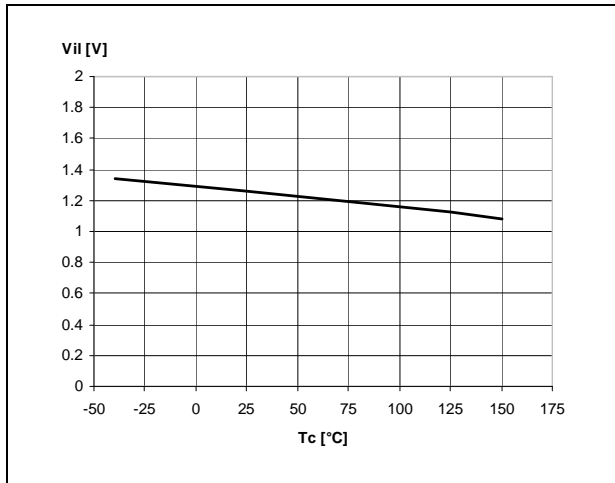


Figure 19. Input hysteresis voltage

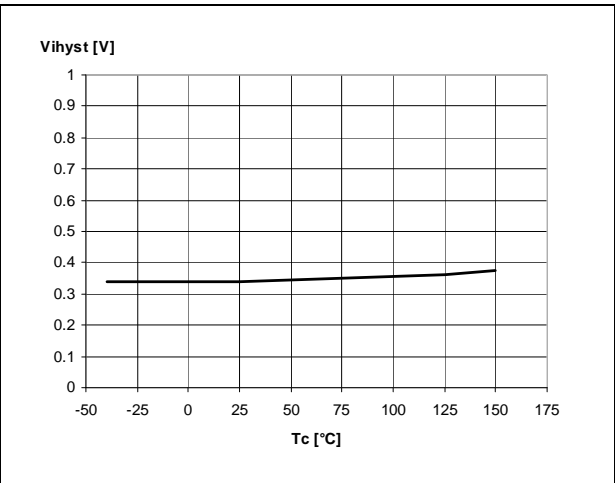


Figure 20. On-state resistance vs  $T_{case}$

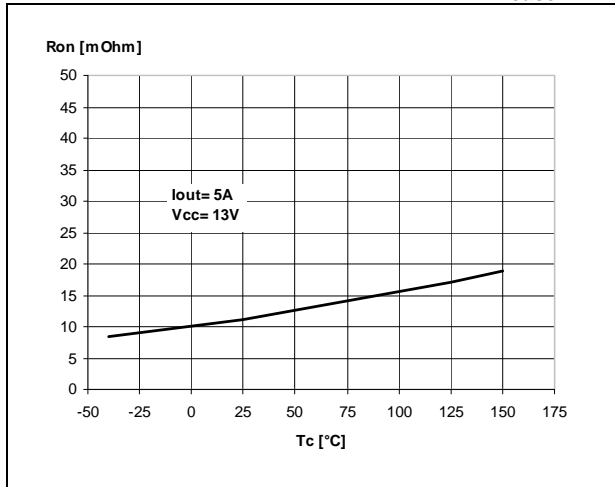


Figure 21. On-state resistance vs  $V_{CC}$

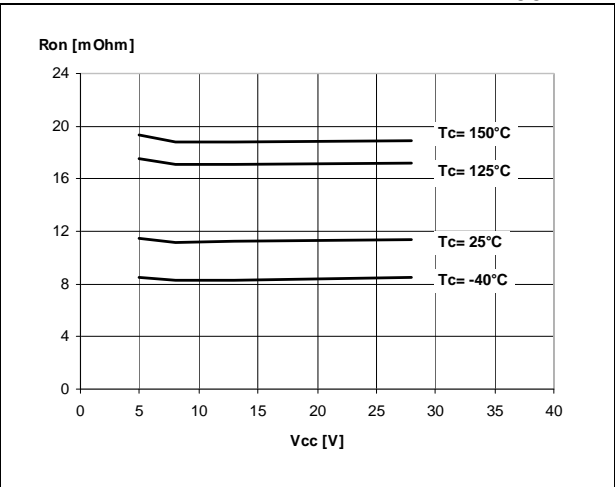


Figure 22. Undervoltage shutdown

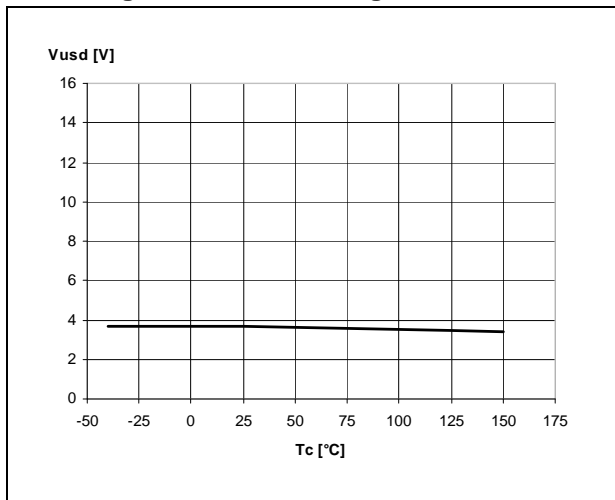


Figure 23.  $I_{LIMH}$  vs  $T_{case}$

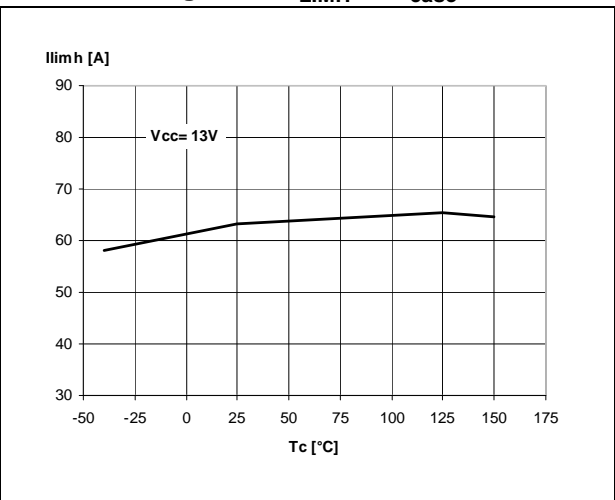


Figure 24. Turn-on voltage slope

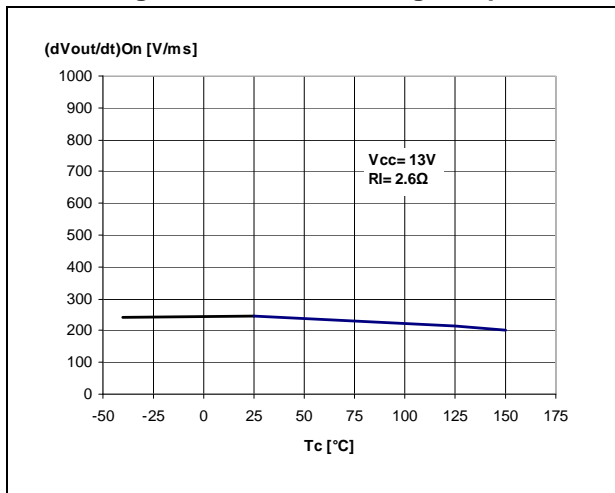


Figure 25. Turn-off voltage slope

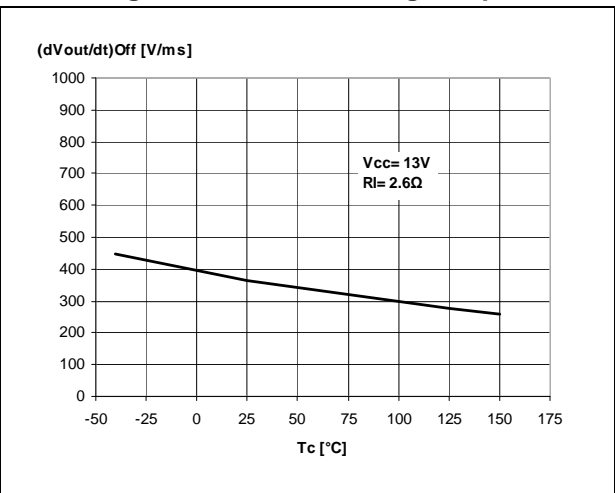


Figure 26. CS\_DIS clamp voltage

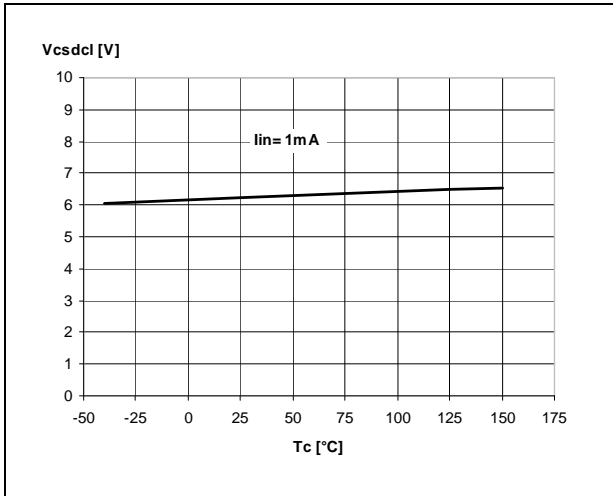


Figure 27. Low level CS\_DIS voltage

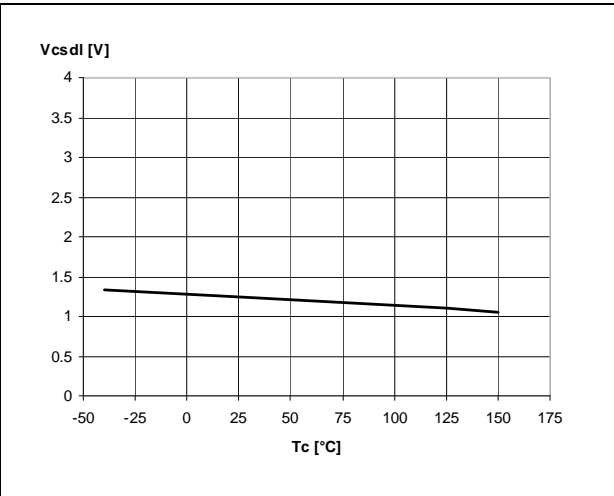
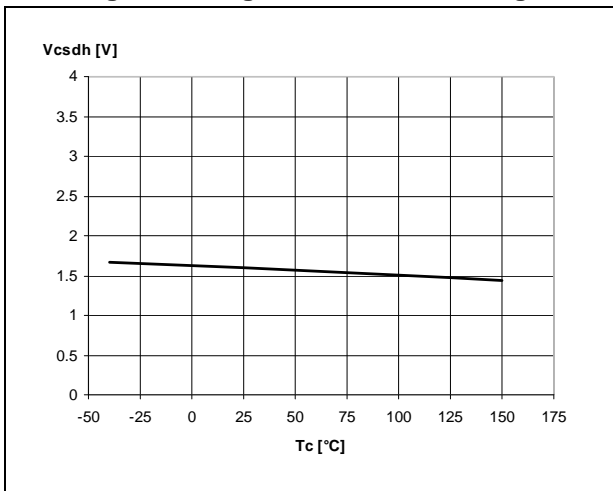
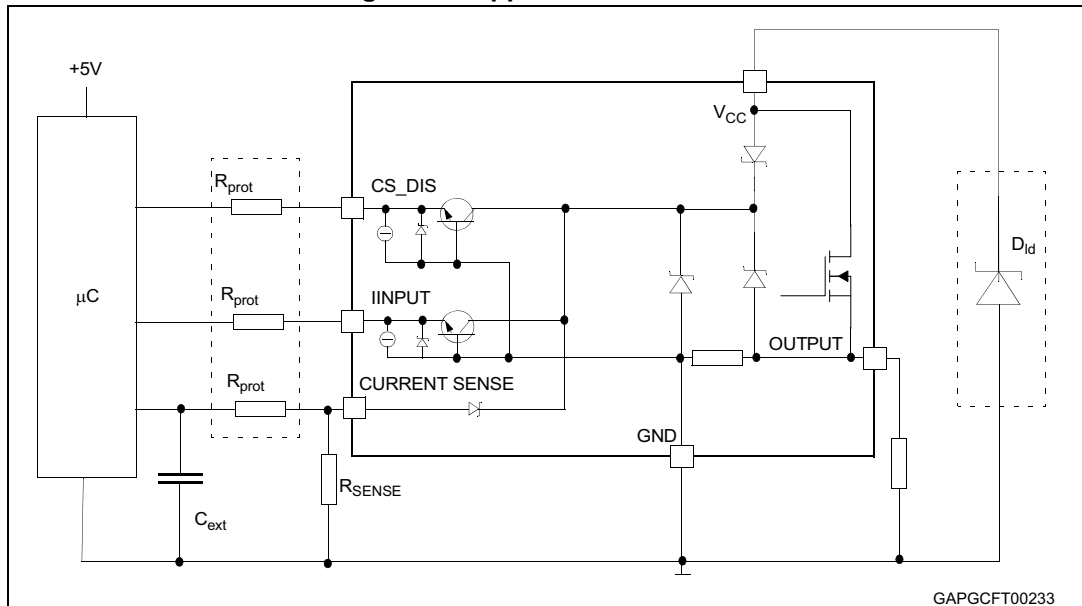


Figure 28. High level CS\_DIS voltage



### 3 Application information

Figure 29. Application schematic



Note: Channel 2 has the same internal circuit as channel 1.

#### 3.1 Load dump protection

D<sub>ld</sub> is necessary (Voltage Transient Suppressor) if the load dump peak voltage exceeds the V<sub>CCPK</sub> max rating. The same applies if the device is subject to transients on the V<sub>CC</sub> line that are greater than the ones shown in the ISO 7637-2: 2004(E) table.

#### 3.2 MCU I/Os protection

When negative transients are present on the V<sub>CC</sub> line, the control pin is pulled negative to approximately -1.5 V. ST suggests to insert a resistor (R<sub>prot</sub>) in line to prevent the microcontroller I/Os pins from latching-up.

The value of these resistors is a compromise between the leakage current of microcontroller and the current required by the HSD I/Os (input levels compatibility) with the latch-up limit of microcontroller I/Os.

##### Equation 1

$$V_{CCpeak} / I_{latchup} \leq R_{prot} \leq (V_{OH\mu C} - V_{IH}) / I_{IHmax}$$

Calculation example:

For V<sub>CCpeak</sub> = - 1.5 V; I<sub>latchup</sub> ≥ 20 mA; V<sub>OHμC</sub> ≥ 4.5 V

$$75 \Omega \leq R_{prot} \leq 240 \text{ k}\Omega.$$

Recommended values:  $R_{prot} = 10\text{ k}\Omega$ ,  $C_{EXT} = 10\text{ nF}$ .

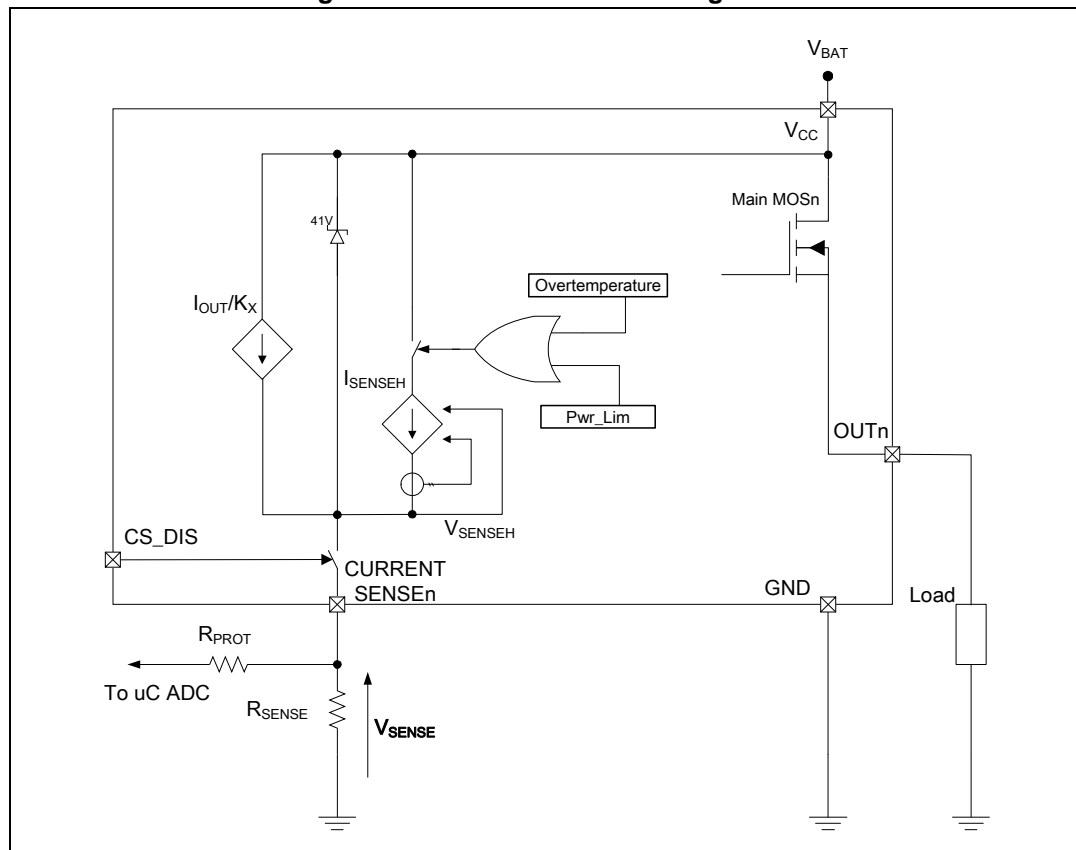
### 3.3 Current sense and diagnostic

The current sense pin performs a double function (see [Figure 30: Current sense and diagnostic](#)):

- **Current mirror of the load current in normal operation**, delivering a current proportional to the load one according to a know ratio  $K_x$ .  
The current  $I_{SENSE}$  can be easily converted to a voltage  $V_{SENSE}$  by means of an external resistor  $R_{SENSE}$ . Linearity between  $I_{OUT}$  and  $V_{SENSE}$  is ensured up to 5V minimum (see parameter  $V_{SENSE}$  in [Table 9: Current sense \(8V < VCC < 18V\)](#)). The current sense accuracy depends on the output current (refer to current sense electrical characteristics [Table 9: Current sense \(8V < VCC < 18V\)](#)).
- **Diagnostic flag in fault conditions**, delivering a fixed voltage  $V_{SENSEH}$  up to a maximum current  $I_{SENSEH}$  in case of the following fault conditions (refer to [Truth table](#)):
  - Power limitation activation
  - Overtemperature

A logic level high on CS\_DIS pin sets at the same time all the current sense pins of the device in a high impedance state, thus disabling the current monitoring and diagnostic detection. This feature allows multiplexing of the microcontroller analog inputs by sharing of sense resistance and ADC line among different devices.

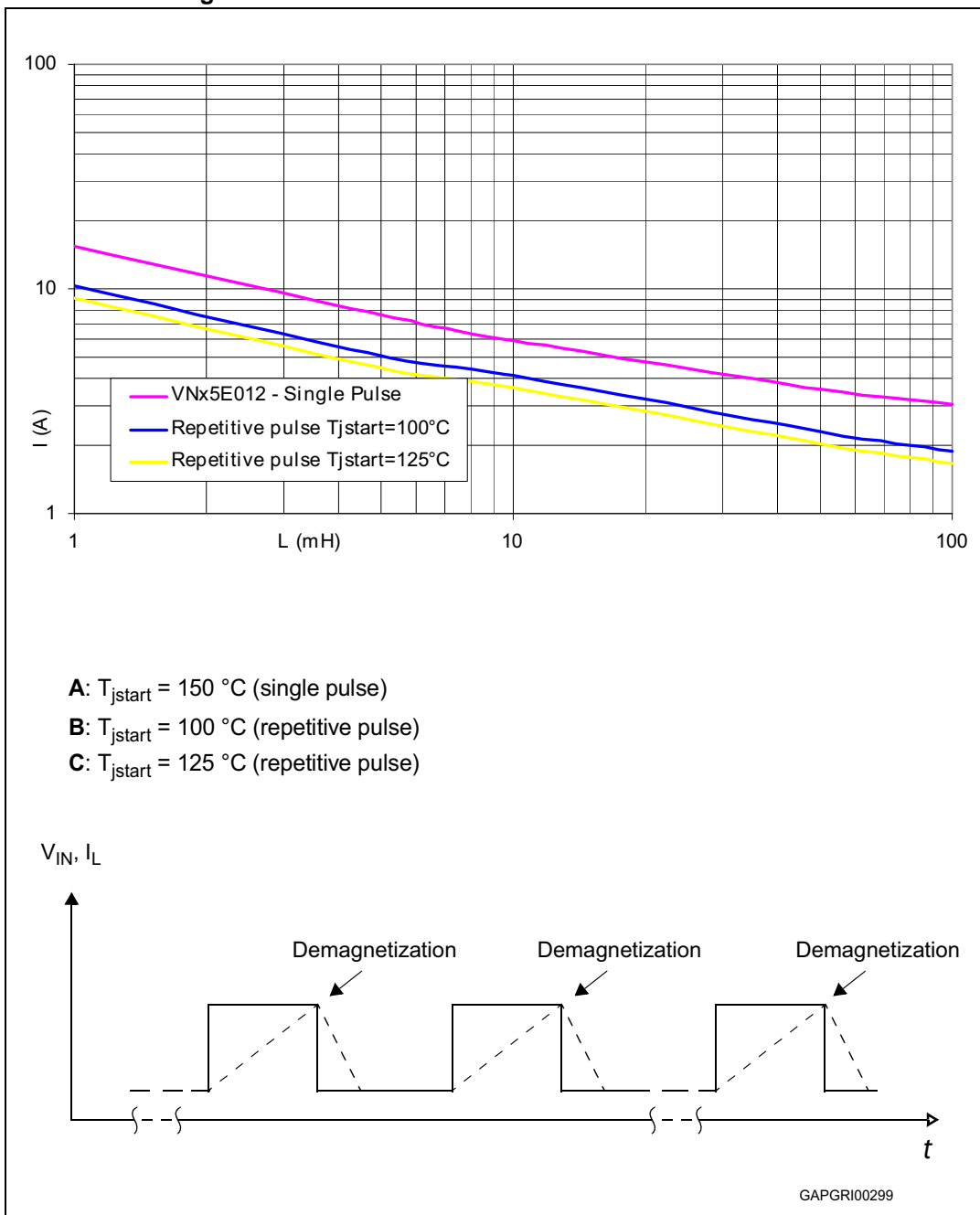
Figure 30. Current sense and diagnostic





### 3.4 Maximum demagnetization energy ( $V_{CC} = 13.5V$ )

Figure 31. Maximum turn-off current versus inductance

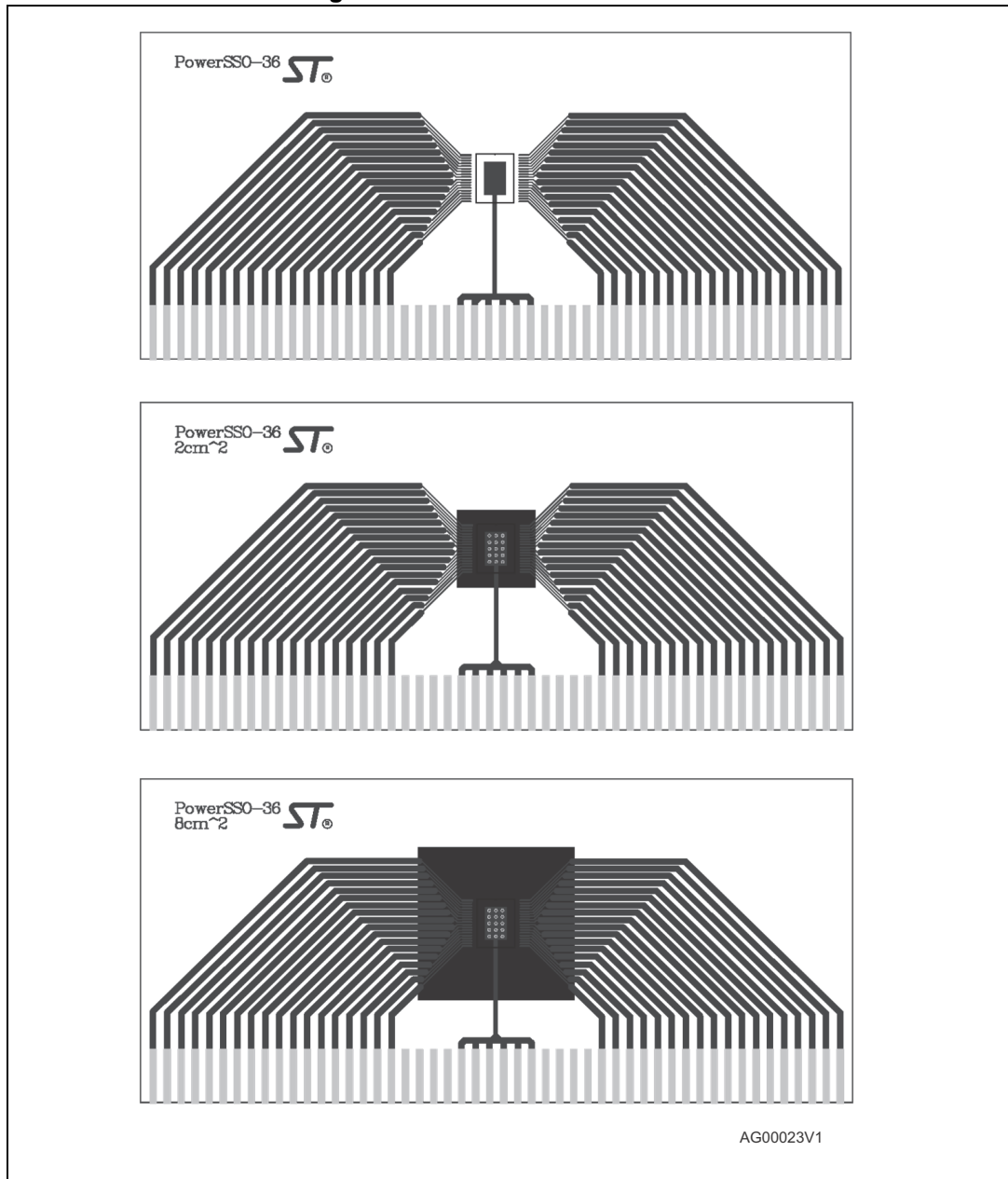


*Note:* Values are generated with  $R_L = 0\ \Omega$ .  
 In case of repetitive pulses,  $T_{jstart}$  (at beginning of each demagnetization) of every pulse must not exceed the temperature specified above for curves A and B.

## 4 Package and PCB thermal data

### 4.1 PowerSSO-36 thermal data

Figure 32. PowerSSO-36 PC board



Note: Layout condition of  $R_{th}$  and  $Z_{th}$  measurements (PCB: Double layer, Thermal Vias, FR4 area= 129mm x 60mm, PCB thickness=1.6mm, Cu thickness=70 $\mu$ m (front and back side), Copper areas: from minimum pad lay-out to 8 cm<sup>2</sup>).

Figure 33.  $R_{thj-amb}$  vs PCB copper area in open box free air condition (one channel ON)

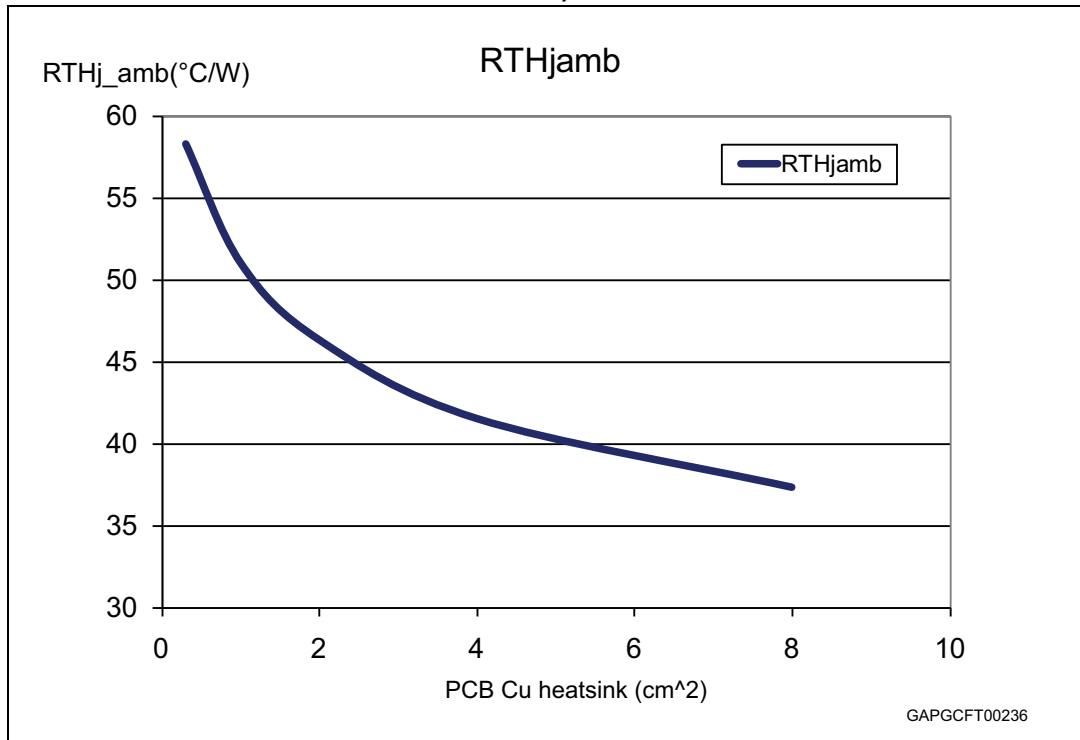


Figure 34. PowerSSO-36 thermal impedance junction ambient single pulse (one channel ON)

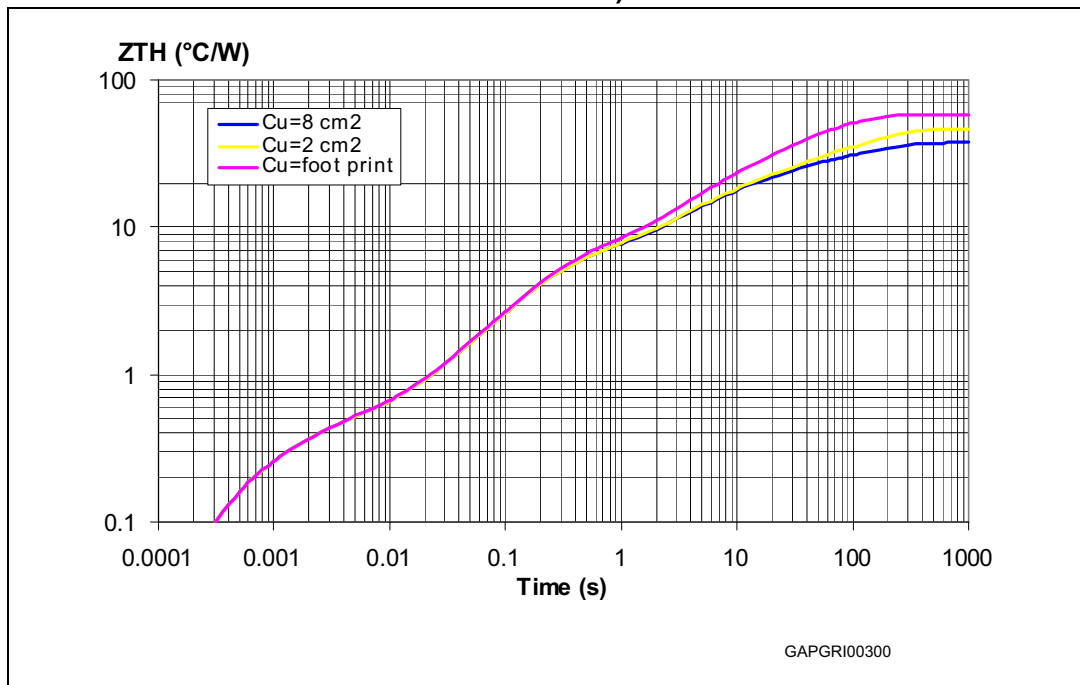
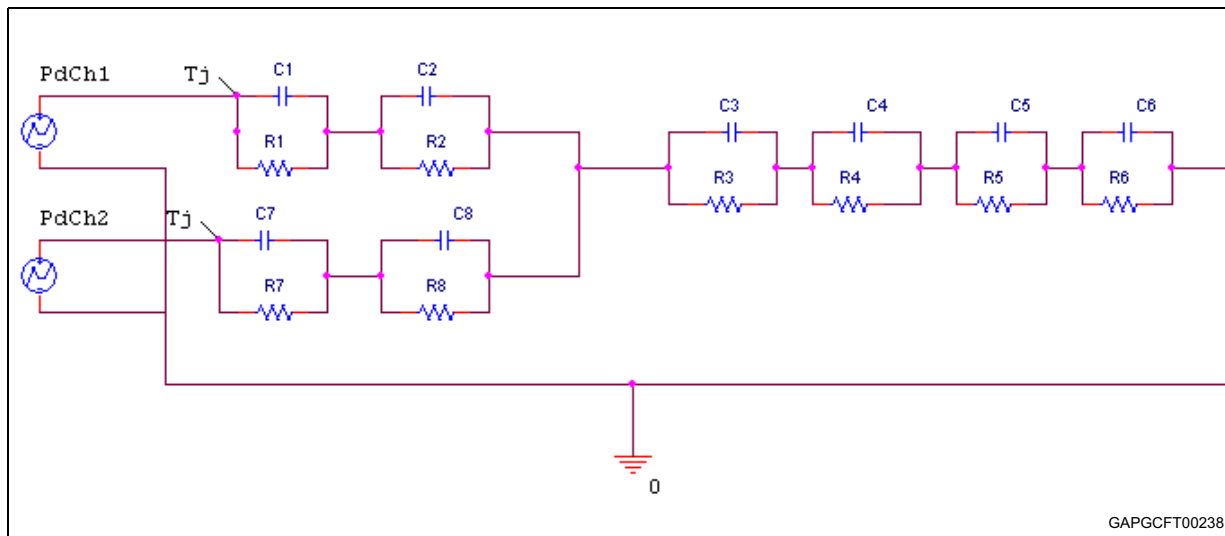


Figure 35. Thermal fitting model of a double channel HSD in PowerSSO-36<sup>(1)</sup>



1. The fitting model is a simplified thermal tool and is valid for transient evolutions where the embedded protections (power limitation or thermal cycling during thermal shutdown) are not triggered.

**Equation 2: pulse calculation formula**

$$Z_{TH\delta} = R_{TH} \cdot \delta + Z_{THtp}(1 - \delta)$$

where  $\delta = t_p/T$

**Table 14. Thermal parameter**

Area/island (cm <sup>2</sup> )	Footprint	2	8
R1 (°C/W)	0.1		
R2 (°C/W)	0.3		
R3 (°C/W)	5		
R4 (°C/W)	8		
R5 (°C/W)	18	10	10
R6 (°C/W)	27	23	14
R7 (°C/W)	0.1		
R8 (°C/W)	0.3		
C1 (W.s/°C)	0.0025		
C2 (W.s/°C)	0.005		
C3 (W.s/°C)	0.04		
C4 (W.s/°C)	0.5		
C5 (W.s/°C)	1	2	2
C6 (W.s/°C)	3	6	9

Table 14. Thermal parameter

Area/island (cm <sup>2</sup> )	Footprint	2	8
C7 (W.s/°C)	0.0025		
C8 (W.s/°C)	0.005		

## 5 Package information

### 5.1 ECOPACK<sup>®</sup> package

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK<sup>®</sup> is an ST trademark.

### 5.2 PowerSSO-36 mechanical data

Figure 36. PowerSSO-36 package dimensions

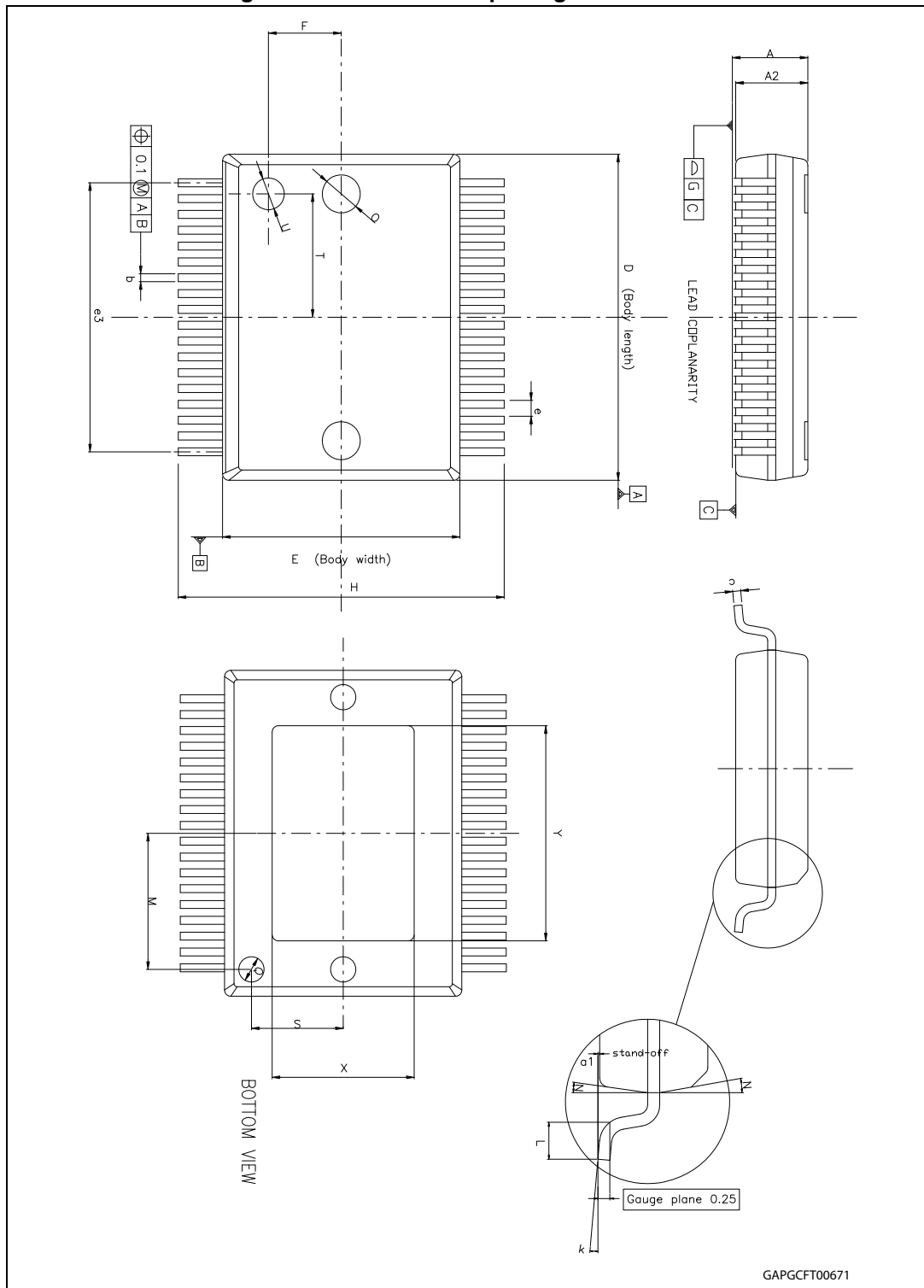


Table 15. PowerSSO-36 mechanical data

Symbol	Millimeters		
	Min.	Typ.	Max.
A	2.15	-	2.47
A2	2.15	-	2.40
a1	0	-	0.075
b	0.18	-	0.36
c	0.23	-	0.32
D	10.10	-	10.50
E	7.4	-	7.6
e	-	0.5	-
e3	-	8.5	-
G	-	-	0.1
G1	-	-	0.06
H	10.1	-	10.5
h	-	-	0.4
L	0.55	-	0.85
N	-	-	10 deg
X	4.1	-	4.7
Y	6.5	-	7.1



### 5.3 Packing information

Figure 37. PowerSSO-36 tube shipment (no suffix)

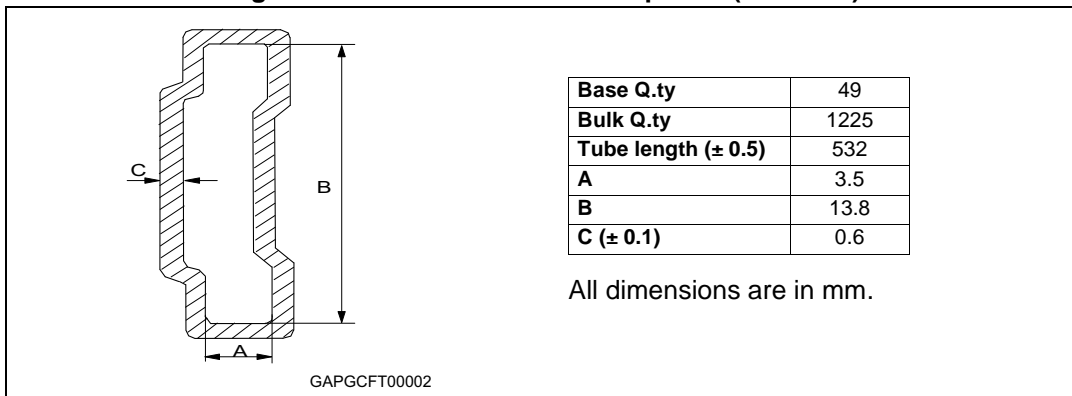
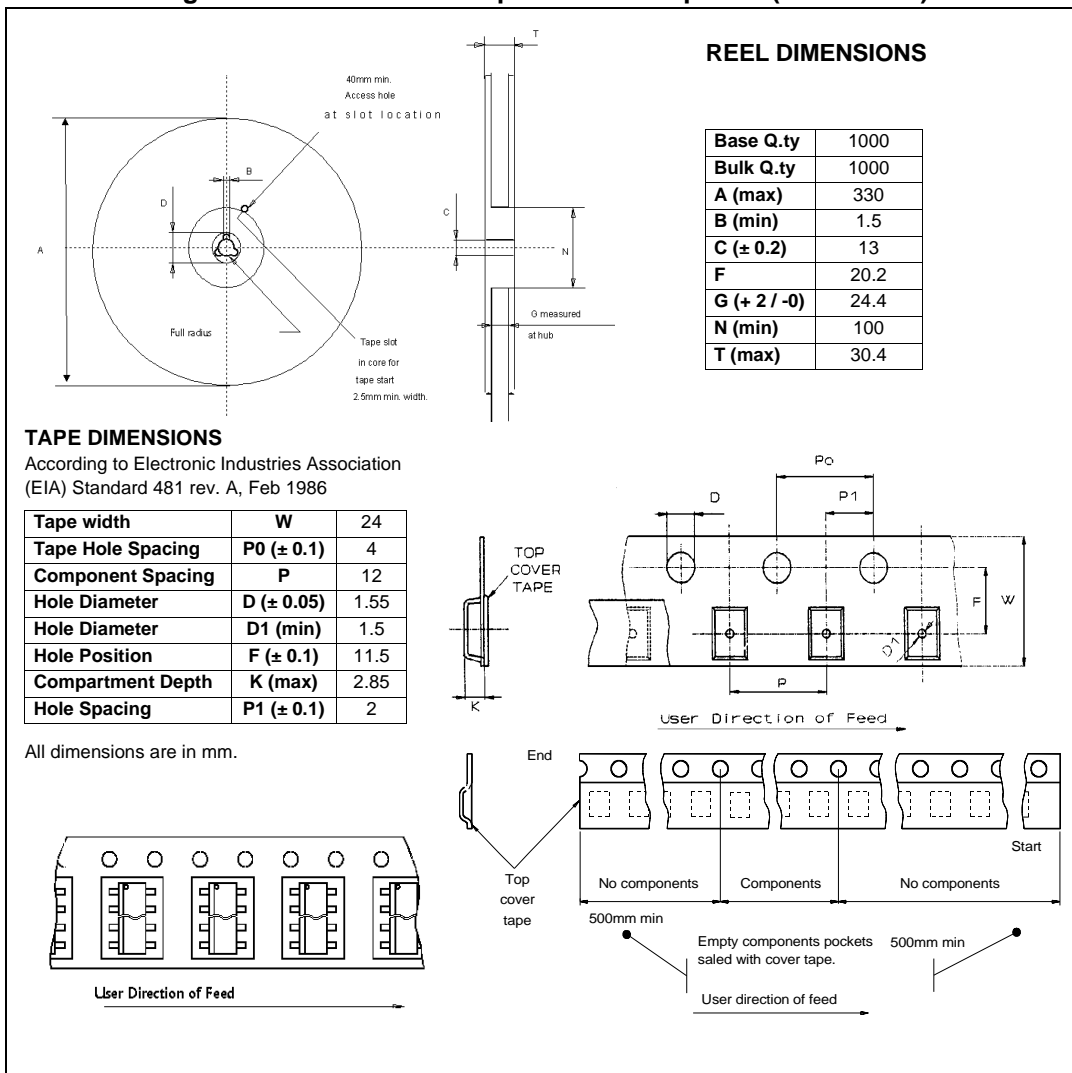


Figure 38. PowerSSO-36 tape and reel shipment (suffix "TR")



## 6 Order codes

Table 16. Device summary

Package	Order codes	
	Tube	Tape and reel
PowerSSO-36	VND5E012MY-E	VND5E012MYTR-E

## 7 Revision history

Table 17. Document revision history

Date	Revision	Changes
21-Oct-2009	1	Initial release.
04-Dec-2009	2	Updated <a href="#">Section 4.1: PowerSSO-36 thermal data</a>
11-July-2012	3	Updated <a href="#">Figure 36: PowerSSO-36 package dimensions</a>
19-Sep-2013	4	Updated Disclaimer.
24-Oct-2013	5	Updated footnote 2 into the <a href="#">Table 11: Electrical transient requirements (part 1)</a> and <a href="#">Table 12: Electrical transient requirements (part 2)</a> .

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